

CoolMOS™ Power Transistor
Features

- Lowest figure-of-merit $R_{ON} \times Q_g$
- Ultra low gate charge
- Extreme dv/dt rated
- High peak current capability
- Qualified for industrial grade applications according to JEDEC¹⁾
- Pb-free lead plating; RoHS compliant; Halogen free mold compound

Product Summary

$V_{DS} @ T_{j,max}$	650	V
$R_{DS(on),max}$	0.125	Ω
$Q_{g,typ}$	53	nC

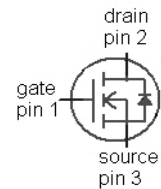
CoolMOS CP is specially designed for:

- Hard switching topologies, for Server and Telecom

PG-TO262



Type	Package	Marking
IPI60R125CP	PG-TO262	6R125P


Maximum ratings, at $T_j=25\text{ °C}$, unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
Continuous drain current	I_D	$T_C=25\text{ °C}$	25	A
		$T_C=100\text{ °C}$	16	
Pulsed drain current ²⁾	$I_{D,pulse}$	$T_C=25\text{ °C}$	82	
Avalanche energy, single pulse	E_{AS}	$I_D=11\text{ A}, V_{DD}=50\text{ V}$	708	mJ
Avalanche energy, repetitive t_{AR} ^{2),3)}	E_{AR}	$I_D=11\text{ A}, V_{DD}=50\text{ V}$	1.2	
Avalanche current, repetitive t_{AR} ^{2),3)}	I_{AR}		11	A
MOSFET dv/dt ruggedness	dv/dt	$V_{DS}=0\dots480\text{ V}$	50	V/ns
Gate source voltage	V_{GS}	static	± 20	V
		AC ($f > 1\text{ Hz}$)	± 30	
Power dissipation	P_{tot}	$T_C=25\text{ °C}$	208	W
Operating and storage temperature	T_j, T_{stg}		-55 ... 150	$^{\circ}\text{C}$

Maximum ratings, at $T_j=25\text{ }^\circ\text{C}$, unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
Continuous diode forward current	I_S	$T_C=25\text{ }^\circ\text{C}$	16	A
Diode pulse current ²⁾	$I_{S,pulse}$		82	
Reverse diode dv/dt ⁴⁾	dv/dt		15	V/ns

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	

Thermal characteristics

Thermal resistance, junction - case	R_{thJC}		-	-	0.6	K/W
Thermal resistance, junction - ambient	R_{thJA}	leaded	-	-	62	
Soldering temperature, wavesoldering only allowed at leads	T_{sold}	1.6 mm (0.063 in.) from case for 10 s	-	-	260	$^\circ\text{C}$

Electrical characteristics, at $T_j=25\text{ }^\circ\text{C}$, unless otherwise specified

Static characteristics

Drain-source breakdown voltage	$V_{(BR)DSS}$	$V_{GS}=0\text{ V}$, $I_D=250\text{ }\mu\text{A}$	600	-	-	V
Gate threshold voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}$, $I_D=1.1\text{ mA}$	2.5	3	3.5	
Zero gate voltage drain current	I_{DSS}	$V_{DS}=600\text{ V}$, $V_{GS}=0\text{ V}$, $T_j=25\text{ }^\circ\text{C}$	-	-	2	μA
		$V_{DS}=600\text{ V}$, $V_{GS}=0\text{ V}$, $T_j=150\text{ }^\circ\text{C}$	-	20	-	
Gate-source leakage current	I_{GSS}	$V_{GS}=20\text{ V}$, $V_{DS}=0\text{ V}$	-	-	100	nA
Drain-source on-state resistance	$R_{DS(on)}$	$V_{GS}=10\text{ V}$, $I_D=16\text{ A}$, $T_j=25\text{ }^\circ\text{C}$	-	0.11	0.125	Ω
		$V_{GS}=10\text{ V}$, $I_D=16\text{ A}$, $T_j=150\text{ }^\circ\text{C}$	-	0.30	-	
Gate resistance	R_G	$f=1\text{ MHz}$, open drain	-	2.1	-	Ω

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	
Dynamic characteristics						
Input capacitance	C_{iss}	$V_{GS}=0\text{ V}$, $V_{DS}=100\text{ V}$, $f=1\text{ MHz}$	-	2500	-	pF
Output capacitance	C_{oss}		-	120	-	
Effective output capacitance, energy related ⁵⁾	$C_{o(er)}$	$V_{GS}=0\text{ V}$, $V_{DS}=0\text{ V}$ to 480 V	-	110	-	
Effective output capacitance, time related ⁶⁾	$C_{o(tr)}$		-	300	-	
Turn-on delay time	$t_{d(on)}$	$V_{DD}=400\text{ V}$, $V_{GS}=10\text{ V}$, $I_D=16\text{ A}$, $R_G=3.3\ \Omega$	-	15	-	ns
Rise time	t_r		-	5	-	
Turn-off delay time	$t_{d(off)}$		-	50	-	
Fall time	t_f		-	5	-	
Gate Charge Characteristics						
Gate to source charge	Q_{gs}	$V_{DD}=400\text{ V}$, $I_D=16\text{ A}$, $V_{GS}=0\text{ to }10\text{ V}$	-	12	-	nC
Gate to drain charge	Q_{gd}		-	18	-	
Gate charge total	Q_g		-	53	70	
Gate plateau voltage	$V_{plateau}$		-	5.0	-	V
Reverse Diode						
Diode forward voltage	V_{SD}	$V_{GS}=0\text{ V}$, $I_F=16\text{ A}$, $T_j=25\text{ }^\circ\text{C}$	-	0.9	1.2	V
Reverse recovery time	t_{rr}	$V_R=400\text{ V}$, $I_F=I_S$, $di_F/dt=100\text{ A}/\mu\text{s}$	-	430	-	ns
Reverse recovery charge	Q_{rr}		-	9	-	μC
Peak reverse recovery current	I_{rrm}		-	42	-	A

¹⁾ J-STD20 and JESD22

²⁾ Pulse width t_p limited by $T_{j,max}$

³⁾ Repetitive avalanche causes additional power losses that can be calculated as $P_{AV}=E_{AR} \cdot f$.

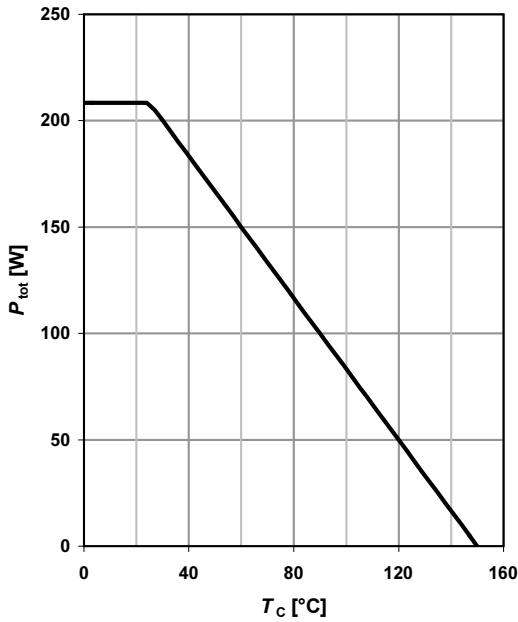
⁴⁾ $I_{SD}=I_D$, $di/dt \leq 200\text{ A}/\mu\text{s}$, $V_{DClink}=400\text{ V}$, $V_{peak} < V_{(BR)DSS}$, $T_j < T_{j,max}$, identical low side and high side switch.

⁵⁾ $C_{o(er)}$ is a fixed capacitance that gives the same stored energy as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS} .

⁶⁾ $C_{o(tr)}$ is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS} .

1 Power dissipation

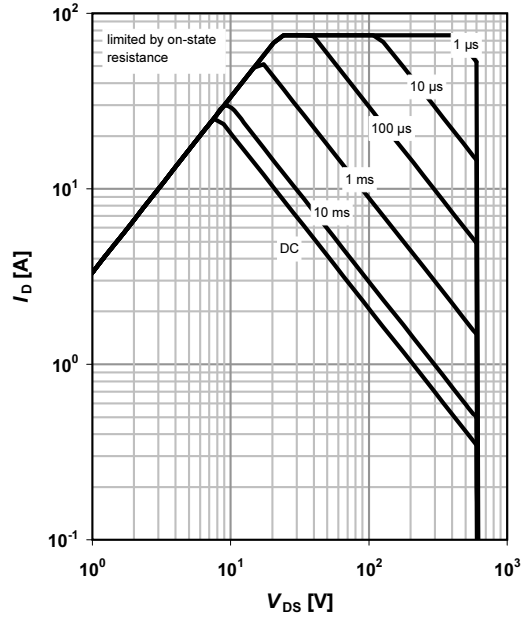
$$P_{tot} = f(T_C)$$



2 Safe operating area

$$I_D = f(V_{DS}); T_C = 25\text{ °C}; D = 0$$

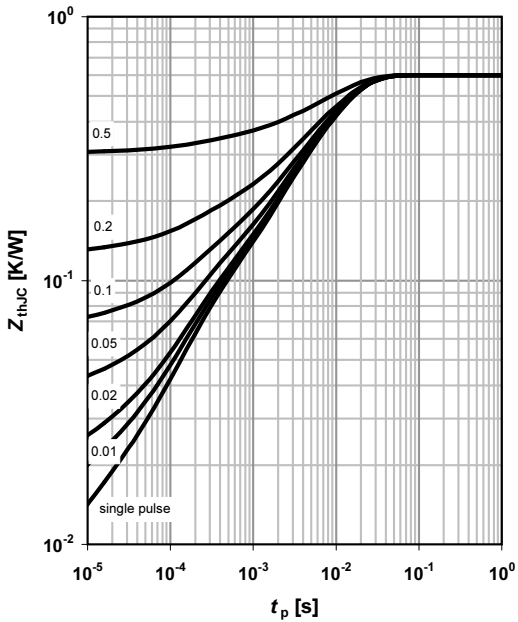
parameter: t_p



3 Max. transient thermal impedance

$$Z_{thJC} = f(t_p)$$

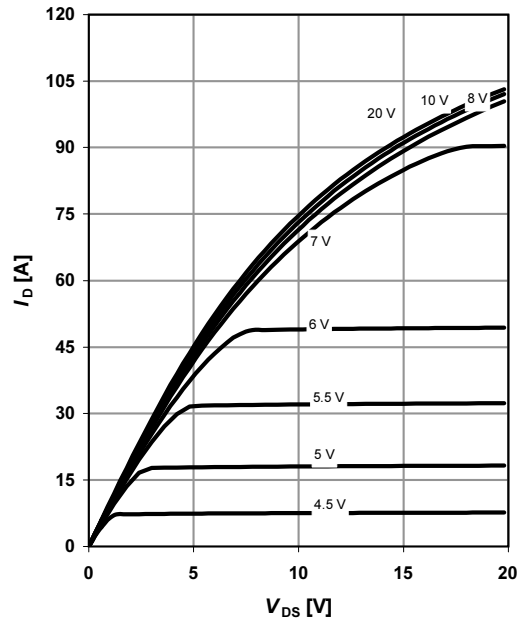
parameter: $D = t_p/T$



4 Typ. output characteristics

$$I_D = f(V_{DS}); T_J = 25\text{ °C}$$

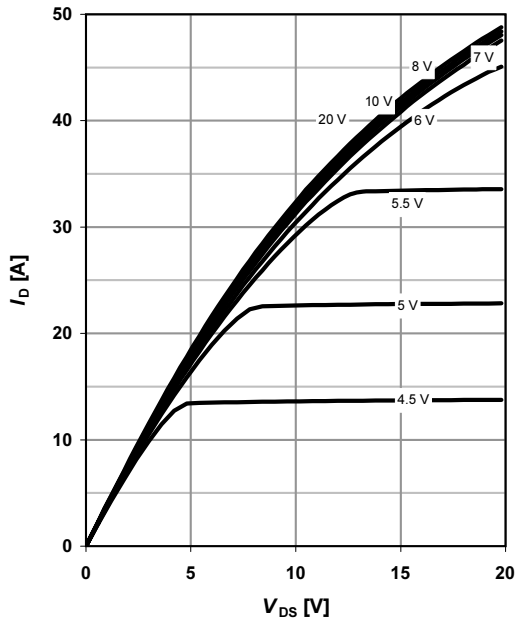
parameter: V_{GS}



5 Typ. output characteristics

$I_D = f(V_{DS}); T_j = 150\text{ }^\circ\text{C}$

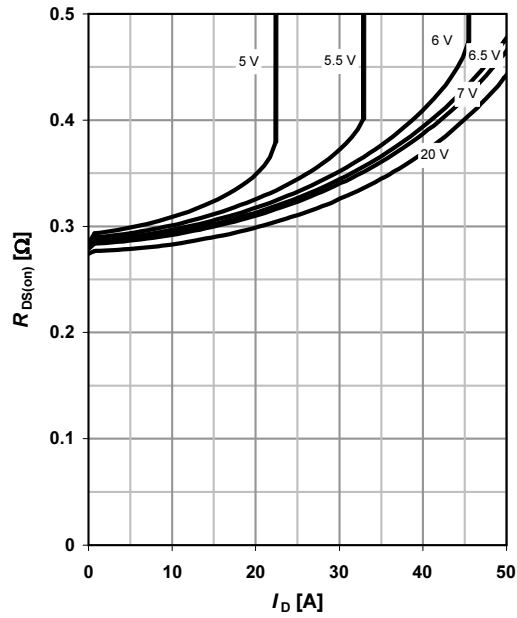
parameter: V_{GS}



6 Typ. drain-source on-state resistance

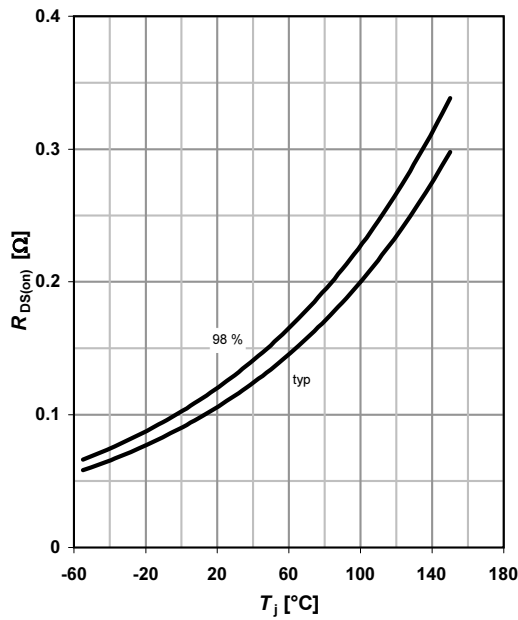
$R_{DS(on)} = f(I_D); T_j = 150\text{ }^\circ\text{C}$

parameter: V_{GS}



7 Drain-source on-state resistance

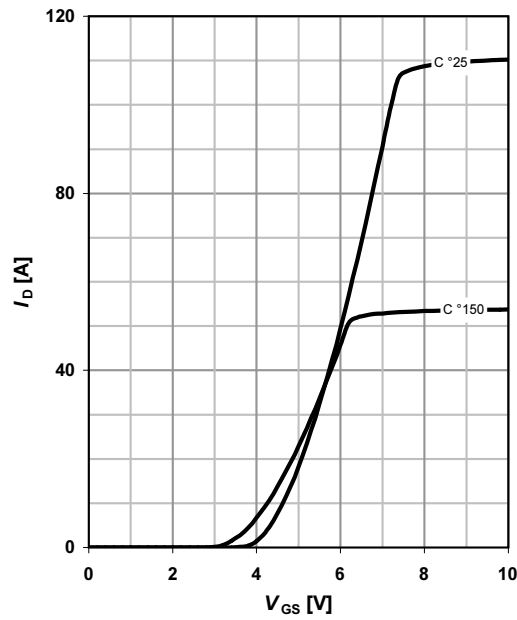
$R_{DS(on)} = f(T_j); I_D = 16\text{ A}; V_{GS} = 10\text{ V}$



8 Typ. transfer characteristics

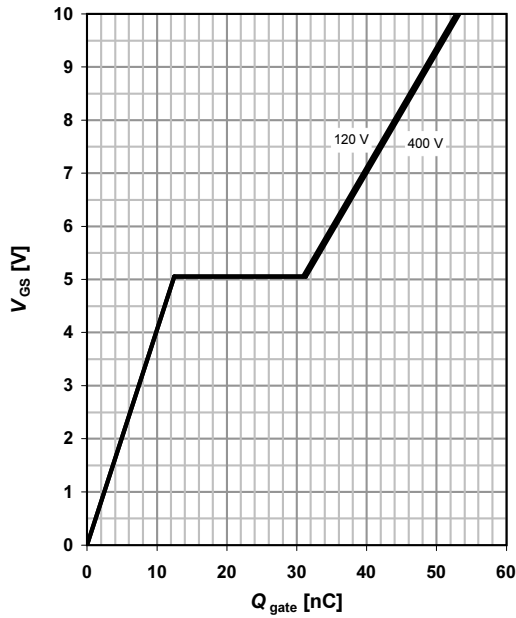
$I_D = f(V_{GS}); |V_{DS}| > 2|I_D|R_{DS(on)max}$

parameter: T_j

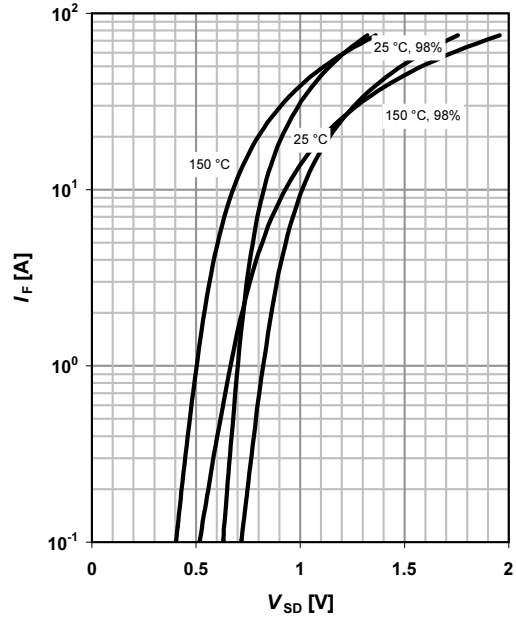


9 Typ. gate charge

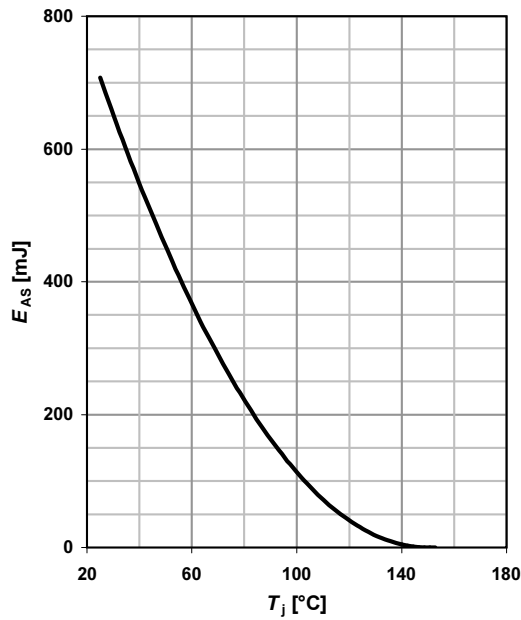
$$V_{GS} = f(Q_{gate}); I_D = 16 \text{ A pulsed}$$

 parameter: V_{DD}

10 Forward characteristics of reverse diode

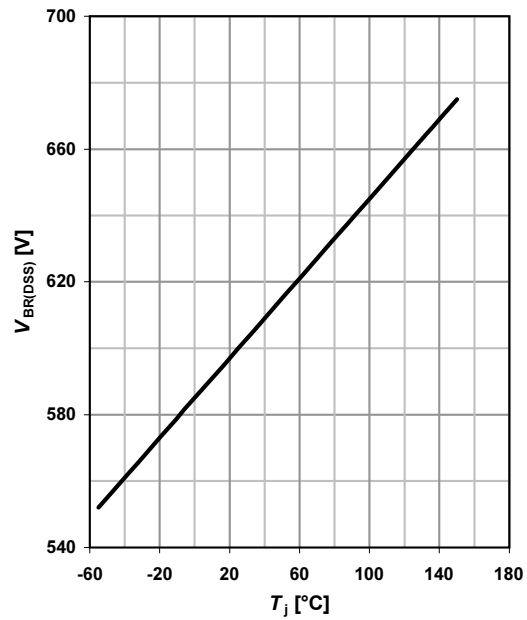
$$I_F = f(V_{SD})$$

 parameter: T_j

11 Avalanche energy

$$E_{AS} = f(T_j); I_D = 11 \text{ A}; V_{DD} = 50 \text{ V}$$

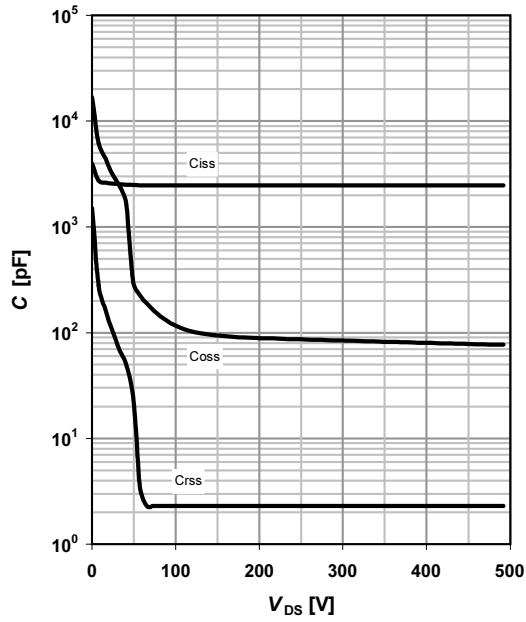

12 Drain-source breakdown voltage

$$V_{BR(DSS)} = f(T_j); I_D = 0.25 \text{ mA}$$



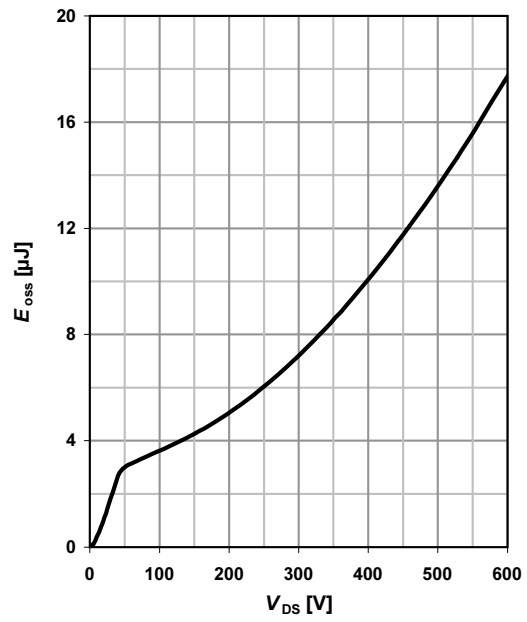
13 Typ. capacitances

$C=f(V_{DS}); V_{GS}=0\text{ V}; f=1\text{ MHz}$

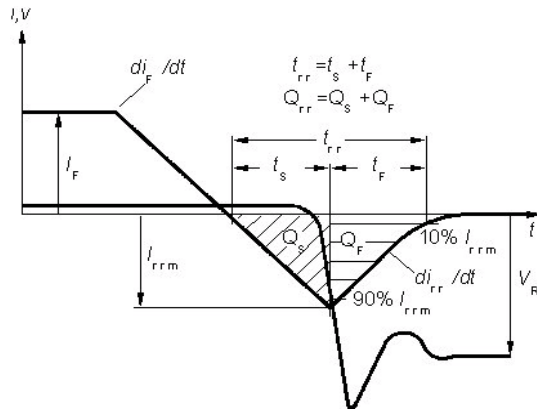


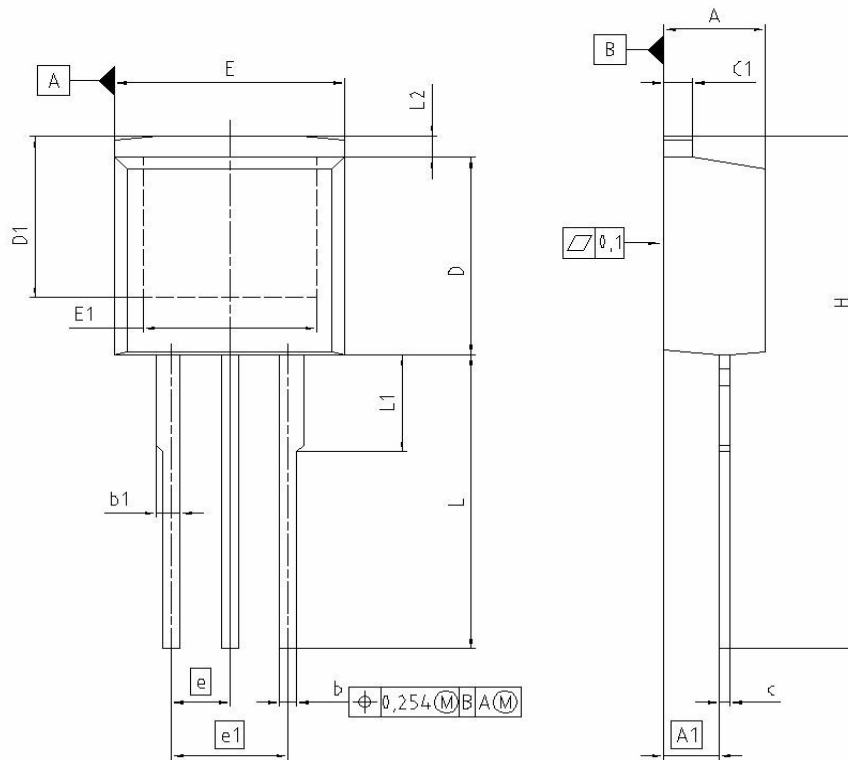
14 Typ. Coss stored energy

$E_{oss}=f(V_{DS})$



Definition of diode switching characteristics



PG-TO262-3-1: Outlines


DIM	MILLIMETERS		INCHES	
	MIN	MAX	MIN	MAX
A	4.300	4.500	0.169	0.177
A1	2.150	2.650	0.085	0.104
b	0.650	0.850	0.026	0.033
b1	0.635	1.400	0.025	0.055
c	0.400	0.600	0.016	0.024
c1	1.170	1.370	0.046	0.054
D	9.050	9.450	0.356	0.372
D1	6.900	7.650	0.272	0.301
E	9.800	10.200	0.386	0.402
E1	7.250	8.600	0.285	0.339
e	2.540		0.100	
e1	5.080		0.200	
N	3		3	
L	13.000	14.000	0.512	0.551
L1	4.350	4.750	0.171	0.187
L2	0.700	1.300	0.028	0.051

REFERENCE
JEDEC TO262

SCALE

EUROPEAN PROJECTION

ISSUE DATE
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FILE
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